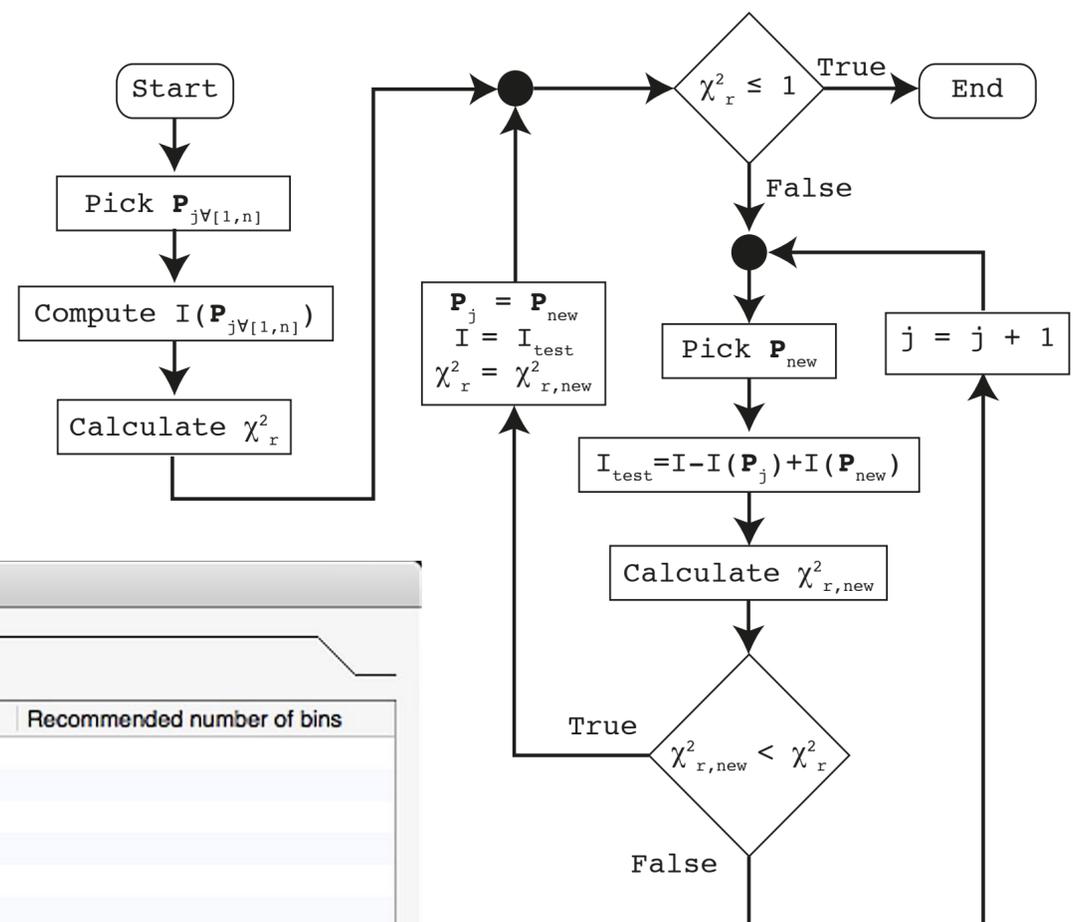
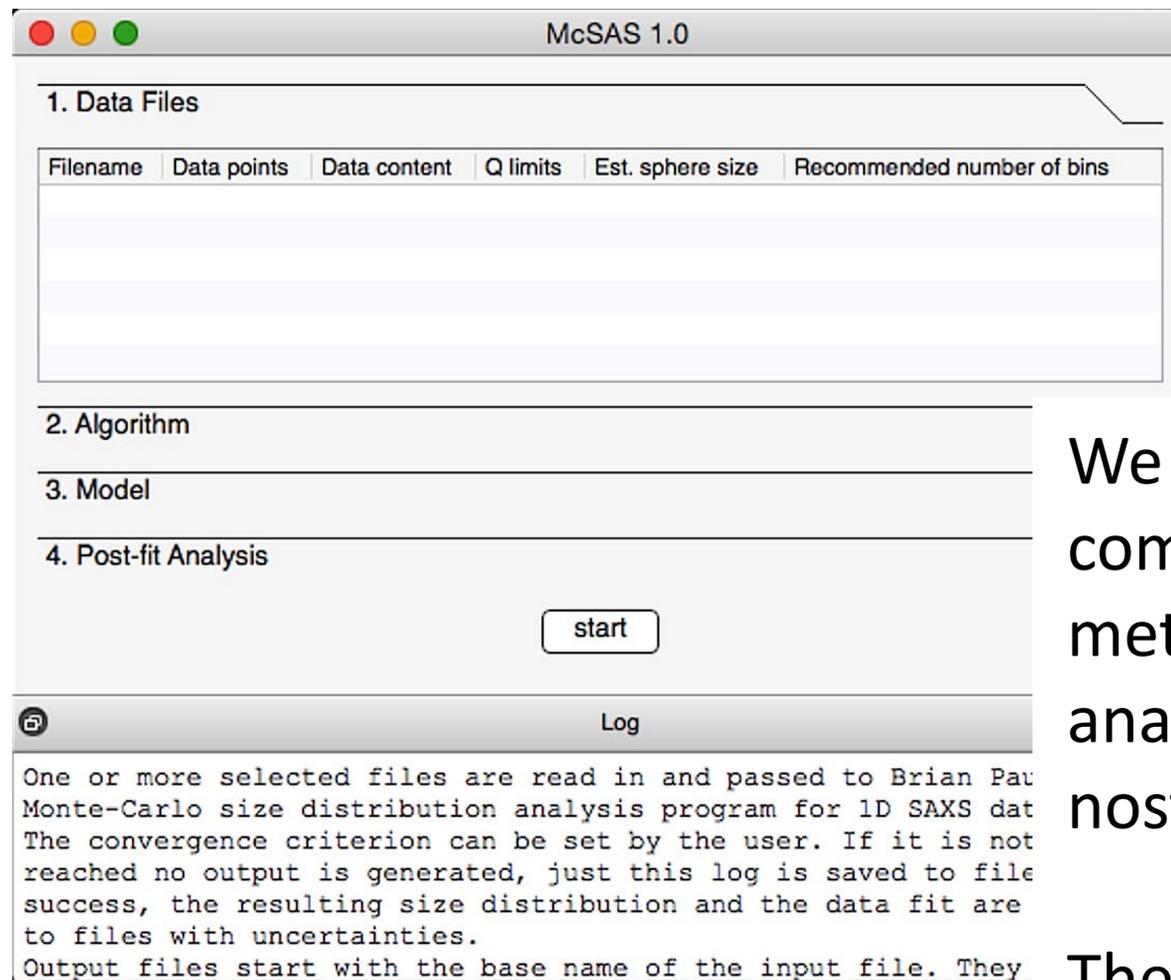


Applications of McSAS:

Software for the retrieval of parameter distributions from small-angle scattering patterns

Small-angle scattering can do what electron microscopy never could: provide nanostructural details for vast amounts of material with little fuss...

However, data correction and analysis has remained complicated.



We are, therefore, developing comprehensive data correction methodology¹ and Monte Carlo analysis methods² for unbiased nanostructure information retrieval

These are some of the Monte Carlo results so far.. [1]